

**UNISONIC TECHNOLOGIES CO., LTD** 

## 1N60

# 1.2A, 600V N-CHANNEL **POWER MOSFET**

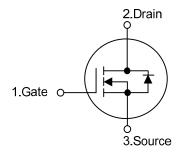
#### DESCRIPTION

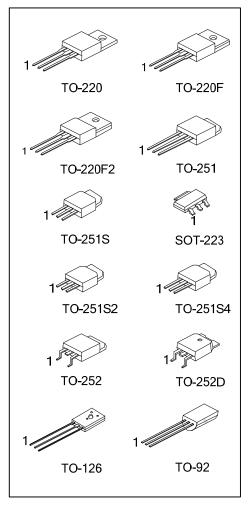
The UTC 1N60 is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

#### **FEATURES**

- \* R<sub>DS(ON)</sub> <11.5Ω@ V<sub>GS</sub>=10V, I<sub>D</sub>=0.6A
- \* Ultra Low gate charge (typical 5.0nC)
- \* Low reverse transfer capacitance (C<sub>RSS</sub> = typical 3.0 pF)
- \* Fast switching capability
- \* Avalanche energy specified
- \* Improved dv/dt capability, high ruggedness

#### SYMBOL



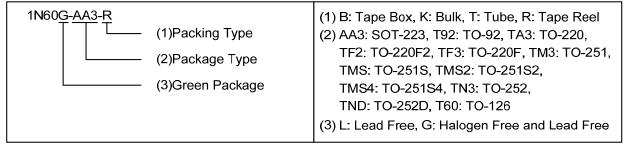


### Power MOSFET

#### **ORDERING INFORMATION**

Ordering Number		Deelvere	Pin Assignment			Dealizer	
Lead Free	Halogen Free	Package	1 2		3	Packing	
-	1N60G-AA3-R	SOT-223	G	D	S	Tape Reel	
1N60L-TA3-T	1N60G-TA3-T	TO-220	G	D	S	Tube	
1N60L-TF2-T	1N60G-TF2-T	TO-220F2	G	D	S	Tube	
1N60L-TF3-T	1N60G-TF3-T	TO-220F	G	D	S	Tube	
1N60L-TM3-T	1N60G-TM3-T	TO-251	G	D	S	Tube	
1N60L-TMS-T	1N60G-TMS-T	TO-251S	G	D	S	Tube	
1N60L-TMS2-T	1N60G-TMS2-T	TO-251S2	G	D	S	Tube	
1N60L-TMS4-T	1N60G-TMS4-T	TO-251S4	G	D	S	Tube	
1N60L-TN3-R	1N60G-TN3-R	TO-252	G	D	S	Tape Reel	
1N60L-TND-R	1N60G-TND-R	TO-252D	G	D	S	Tape Reel	
1N60L-T60-K	1N60G-T60-K	TO-126	G	D	S	Bulk	
1N60L-T92-B	1N60G-T92-B	TO-92	G	D	S	Tape Box	
1N60L-T92-K	1N60G-T92-K	TO-92	G	D	S	Bulk	

Pin Assignment: G: Gate D: Drain S: Source Note:



#### MARKING

PAC	KAGE	MARKING		
SOT-223		1N60G □□□□ → Data Code 1		
TO-220 TO-220F TO-220F2 TO-251 TO-251S	TO-251S2 TO-251S4 TO-252 TO-252D	UTC 1N60 □ L: Lead Free G: Halogen Free → Data Code 1		
TO-126		UTC DDD 1N60 Data Code L: Lead Free G: Halogen Free		
TO-92		U T C $1N60 - G: Halogen Free$ $G: Halogen Free$ $D = Data Code$ $1$		



PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage	)	V <sub>DSS</sub>	600	V
Gate-Source Voltage		V <sub>GSS</sub>	±30	V
Avalanche Current (N	lote 2)	I <sub>AR</sub>	1.2	Α
Continuous Drain Cu	rrent	I <sub>D</sub>	1.2	Α
Pulsed Drain Current	(Note 2)	I <sub>DM</sub>	4.8	Α
Augusta and a Francisco	Single Pulsed (Note 3)	E <sub>AS</sub>	50	mJ
Avalanche Energy	Repetitive (Note 2)	E <sub>AR</sub>	4.0	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
	SOT-223		8	
	TO-251/TO-252 TO-252D/TO-251S TO-251S2/ TO-251S4		28	
Power Dissipation	TO-220	PD	40	W
	TO-220F		21	
	TO-220F2		23	
	TO-92(T <sub>A</sub> =25°C)		1	
	TO-126		12.5	
Junction Temperature	9	TJ	+150	°C
Operating Temperatu	re	T <sub>OPR</sub>	-55 ~ +150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

#### ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>c</sub> = 25°C, unless otherwise specified)

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature

3. L = 60mH,  $I_{AS}$  = 1A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C

4.  $I_{SD} \le 1.2A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 

#### THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	SOT-223		150	
	TO-251/TO-252	θ <sub>JA</sub>		
	TO-252D/TO-251S		110	
	TO-251S2/ TO-251S4			°C/W
	TO-220/TO-220F		62.5	C/VV
	TO-220F2		62.5	
	TO-92		140	
	TO-126		132	
	SOT-223		14	
	TO-251/TO-252			
	TO-252D/TO-251S		4.53	
Junction to Case	TO-251S2/ TO-251S4			
	TO-220	θ <sub>Jc</sub>	3.13	°C/W
	TO-220F		5.95	
	TO-220F2		5.43	
	TO-92		80	
	TO-126		10	



#### ■ ELECTRICAL CHARACTERISTICS (Tc=25°C, unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	600			V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V			10	μA
Forward		V <sub>GS</sub> =30V, V <sub>DS</sub> =0V			100	nA
Gate-Source Leakage Current Reverse	I <sub>GSS</sub>	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
Breakdown Voltage Temperature Coefficient	: △BV <sub>DSS</sub> /△T <sub>J</sub>	I <sub>D</sub> =250μA		0.4		V/°C
ON CHARACTERISTICS						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	2.0		4.0	V
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =0.6A		9.3	11.5	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C <sub>ISS</sub>			120	150	pF
Output Capacitance	C <sub>OSS</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1MHz		20	25	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			3.0	4.0	pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>D(ON)</sub>			5	20	ns
Turn-On Rise Time	t <sub>R</sub>	$V_{DD}$ =300V, $I_{D}$ =1.2A, $R_{G}$ =50 $\Omega$		25	60	ns
Turn-Off Delay Time	t <sub>D(OFF)</sub>	(Note 2,3)		7	25	ns
Turn-Off Fall Time	t⊨			25	60	ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DS</sub> =480V, V <sub>GS</sub> =10V, I <sub>D</sub> =1.2A		5.0	6.0	nC
Gate-Source Charge	Q <sub>GS</sub>			1.0		nC
Gate-Drain Charge	$Q_{GD}$	(Note 2,3)		2.6		nC
SOURCE-DRAIN DIODE RATINGS AND C	HARACTERIS1	TICS				
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =1.2A			1.4	V
Maximum Continuous Drain-Source Diode					4.0	•
Forward Current	I <sub>S</sub>				1.2	A
Maximum Pulsed Drain-Source Diode	I <sub>SM</sub>				4.8	۸
Forward Current					4.0	A
Reverse Recovery Time	t <sub>rr</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =1.2A		160		ns
Reverse Recovery Charge	Q <sub>RR</sub>	dI <sub>F</sub> /dt=100A/µs (Note 1)		0.3		μC

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

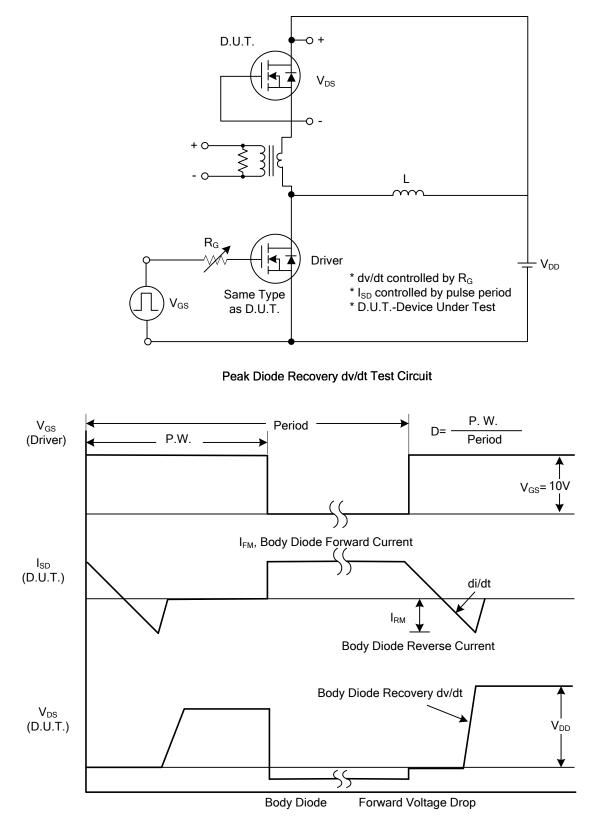
2. Pulse Test: Pulse Width ≤300µs, Duty Cycle≤2%

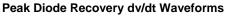
3. Essentially Independent of Operating Temperature



### TEST CIRCUITS AND WAVEFORMS

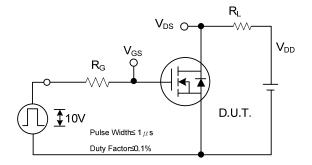
1N60

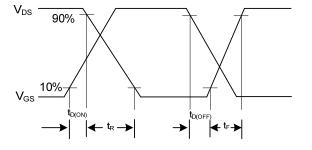




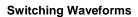


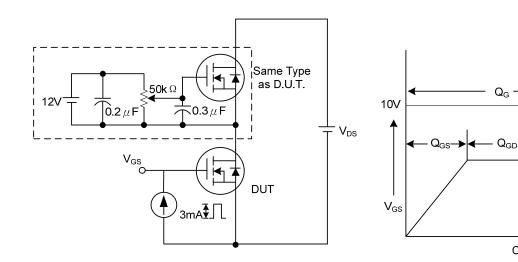
### ■ TEST CIRCUITS AND WAVEFORMS (Cont.)





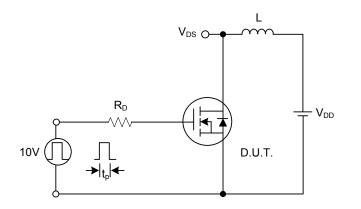
Switching Test Circuit



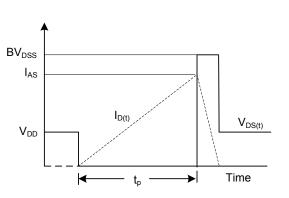


**Gate Charge Test Circuit** 

Charge
Gate Charge Waveform



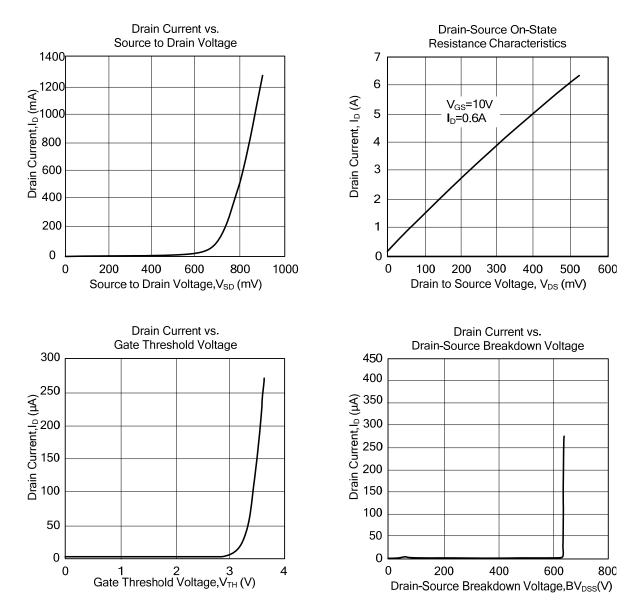
**Unclamped Inductive Switching Test Circuit** 



**Unclamped Inductive Switching Waveforms** 



### TYPICAL CHARACTERISTICS



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